

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/629,815	<b>Applicant(s)/Patent under Reexamination</b>  OHZUKU ET AL.
	<b>Examiner</b>  Cynthia Lee	<b>Art Unit</b>  1745

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IDS	8/29/2006	CL
Inventor search	8/29/2006	CL
EAST search	8/29/2006	CL
STN seach	8/29/2006	CL